

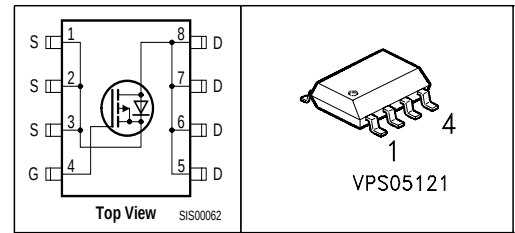
## OptiMOS®-P Small-Signal-Transistor

### Feature

- P-Channel
- Enhancement mode
- Super Logic Level (2.5 V rated)
- 150°C operating temperature
- Avalanche rated
- dv/dt rated

### Product Summary

|              |     |    |
|--------------|-----|----|
| $V_{DS}$     | -20 | V  |
| $R_{DS(on)}$ | 21  | mΩ |
| $I_D$        | -9  | A  |



| Type     | Package | Ordering Code |
|----------|---------|---------------|
| BSO203SP | SO 8    | Q67042-S4083  |

**Maximum Ratings**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                                                                                                                       | Symbol               | Value       | Unit              |
|---------------------------------------------------------------------------------------------------------------------------------|----------------------|-------------|-------------------|
| Continuous drain current<br>$T_A=25^\circ\text{C}$<br>$T_A=70^\circ\text{C}$                                                    | $I_D$                | -9<br>-7.2  | A                 |
| Pulsed drain current<br>$T_A=25^\circ\text{C}$                                                                                  | $I_{D \text{ puls}}$ | -36         |                   |
| Avalanche energy, single pulse<br>$I_D=-9 \text{ A}$ , $V_{DD}=-10\text{V}$ , $R_{GS}=25\Omega$                                 | $E_{AS}$             | 97          | mJ                |
| Reverse diode dv/dt<br>$I_S=-9\text{A}$ , $V_{DS}=-16\text{V}$ , $di/dt=200\text{A}/\mu\text{s}$ , $T_{jmax}=150^\circ\text{C}$ | dv/dt                | -6          | kV/ $\mu\text{s}$ |
| Gate source voltage                                                                                                             | $V_{GS}$             | $\pm 12$    | V                 |
| Power dissipation<br>$T_A=25^\circ\text{C}$                                                                                     | $P_{tot}$            | 2.35        | W                 |
| Operating and storage temperature                                                                                               | $T_j, T_{stg}$       | -55... +150 | $^\circ\text{C}$  |
| IEC climatic category; DIN IEC 68-1                                                                                             |                      | 55/150/56   |                   |

## Thermal Characteristics

| Parameter                                      | Symbol     | Values |      |      | Unit |
|------------------------------------------------|------------|--------|------|------|------|
|                                                |            | min.   | typ. | max. |      |
| Characteristics                                |            |        |      |      |      |
| Thermal resistance, junction - soldering point | $R_{thJS}$ | -      | -    | 35   | K/W  |
| SMD version, device on PCB:                    | $R_{thJA}$ |        |      |      |      |
| @ min. footprint, t < 10s                      |            | -      | -    | 110  |      |
| @ 6 cm <sup>2</sup> cooling area <sup>1)</sup> |            | -      | -    | 53   |      |

## Electrical Characteristics, at $T_j = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified

| Parameter                                                                                                                | Symbol        | Values |             |            | Unit       |
|--------------------------------------------------------------------------------------------------------------------------|---------------|--------|-------------|------------|------------|
|                                                                                                                          |               | min.   | typ.        | max.       |            |
| Static Characteristics                                                                                                   |               |        |             |            |            |
| Drain-source breakdown voltage<br>$V_{GS}=0, I_D=-250\mu A$                                                              | $V_{(BR)DSS}$ | -20    | -           | -          | V          |
| Gate threshold voltage, $V_{GS} = V_{DS}$<br>$I_D=-100\mu A$                                                             | $V_{GS(th)}$  | -0.6   | 0.9         | -1.2       |            |
| Zero gate voltage drain current<br>$V_{DS}=-20V, V_{GS}=0, T_j=25^{\circ}C$<br>$V_{DS}=-20V, V_{GS}=0, T_j=150^{\circ}C$ | $I_{DSS}$     | -<br>- | -0.1<br>-10 | -1<br>-100 | $\mu A$    |
| Gate-source leakage current<br>$V_{GS}=-12V, V_{DS}=0$                                                                   | $I_{GSS}$     | -      | -10         | -100       |            |
| Drain-source on-state resistance<br>$V_{GS}=-2.5V, I_D=-7.1A$                                                            | $R_{DS(on)}$  | -      | 22.3        | 34         | m $\Omega$ |
| Drain-source on-state resistance<br>$V_{GS}=-4.5V, I_D=-9A$                                                              | $R_{DS(on)}$  | -      | 12.9        | 21         |            |

<sup>1</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70  $\mu m$  thick) copper area for drain connection. PCB is vertical without blown air;  $t \leq 10$  sec.

Electrical Characteristics, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Dynamic Characteristics

|                              |              |                                                                             |    |      |     |    |
|------------------------------|--------------|-----------------------------------------------------------------------------|----|------|-----|----|
| Transconductance             | $g_{fs}$     | $ V_{DS}  \geq 2 \cdot  I_D  \cdot R_{DS(on)max}$<br>$I_D = -7.2\text{A}$   | 16 | 33   | -   | S  |
| Input capacitance            | $C_{iss}$    | $V_{GS}=0, V_{DS}=-15\text{V},$<br>$f=1\text{MHz}$                          | -  | 2265 | -   | pF |
| Output capacitance           | $C_{oss}$    |                                                                             | -  | 890  | -   |    |
| Reverse transfer capacitance | $C_{rss}$    |                                                                             | -  | 728  | -   |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=-10\text{V}, V_{GS}=-4.5\text{V},$<br>$I_D=-1\text{A}, R_G=6\Omega$ | -  | 15.6 | 23  | ns |
| Rise time                    | $t_r$        |                                                                             | -  | 27   | 40  |    |
| Turn-off delay time          | $t_{d(off)}$ |                                                                             | -  | 58   | 77  |    |
| Fall time                    | $t_f$        |                                                                             | -  | 69   | 104 |    |

### Gate Charge Characteristics

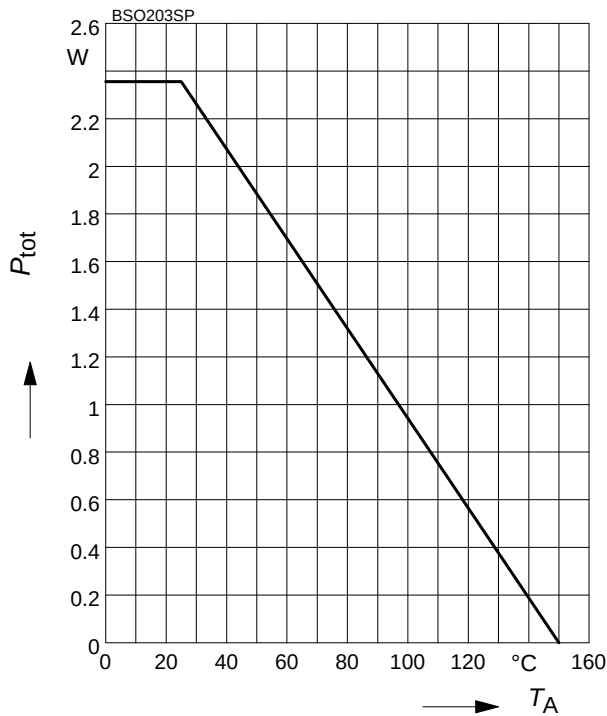
|                       |                 |                                                                              |   |       |       |    |
|-----------------------|-----------------|------------------------------------------------------------------------------|---|-------|-------|----|
| Gate to source charge | $Q_{gs}$        | $V_{DD}=-15\text{V}, I_D=-9\text{A}$                                         | - | -3.8  | -5.7  | nC |
| Gate to drain charge  | $Q_{gd}$        |                                                                              | - | -15.6 | -23.4 |    |
| Gate charge total     | $Q_g$           | $V_{DD}=-15\text{V}, I_D=-9\text{A},$<br>$V_{GS}=0 \text{ to } -4.5\text{V}$ | - | -33.6 | -50.4 |    |
| Gate plateau voltage  | $V_{(plateau)}$ | $V_{DD}=-15\text{V}, I_D=-9\text{A}$                                         | - | -1.6  | -     | V  |

### Reverse Diode

|                                          |          |                                                                        |   |       |       |    |
|------------------------------------------|----------|------------------------------------------------------------------------|---|-------|-------|----|
| Inverse diode continuous forward current | $I_S$    | $T_A=25^\circ\text{C}$                                                 | - | -     | -3    | A  |
| Inverse diode direct current, pulsed     | $I_{SM}$ |                                                                        | - | -     | -36   |    |
| Inverse diode forward voltage            | $V_{SD}$ | $V_{GS}=0,  I_F  =  I_D $                                              | - | -0.82 | -1.25 | V  |
| Reverse recovery time                    | $t_{rr}$ | $V_R=-10\text{V},  I_F  =  I_D ,$<br>$di_F/dt=100\text{A}/\mu\text{s}$ | - | 34    | 42    | ns |
| Reverse recovery charge                  | $Q_{rr}$ |                                                                        | - | 16.7  | 21    | nC |

### 1 Power dissipation

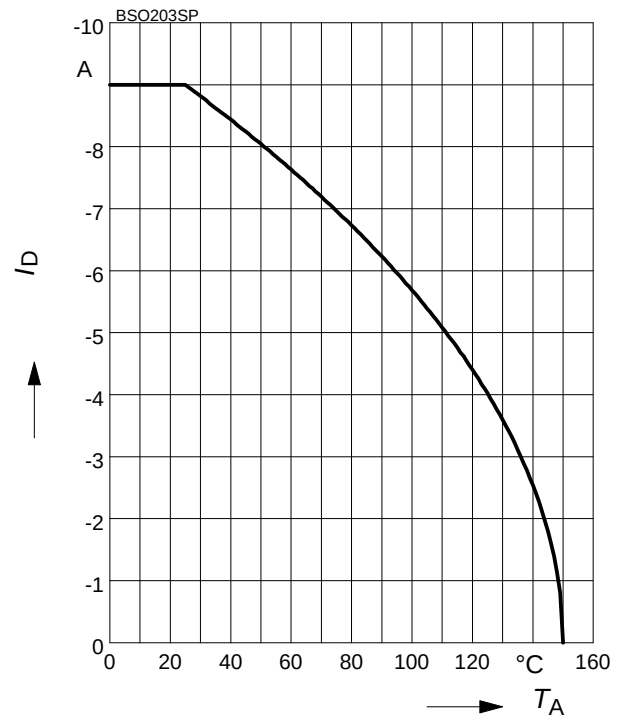
$$P_{\text{tot}} = f(T_A)$$



### 2 Drain current

$$I_D = f(T_A)$$

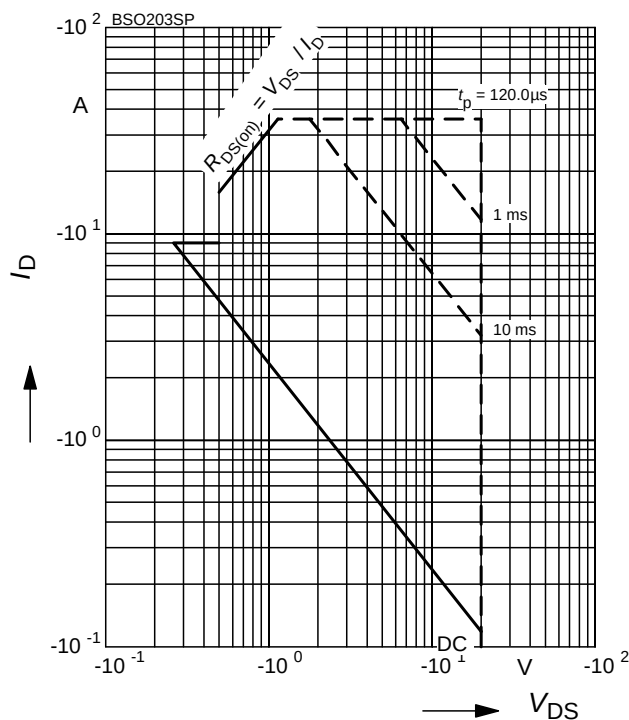
parameter:  $|V_{GS}| \geq 4.5 \text{ V}$



### 3 Safe operating area

$$I_D = f(V_{DS})$$

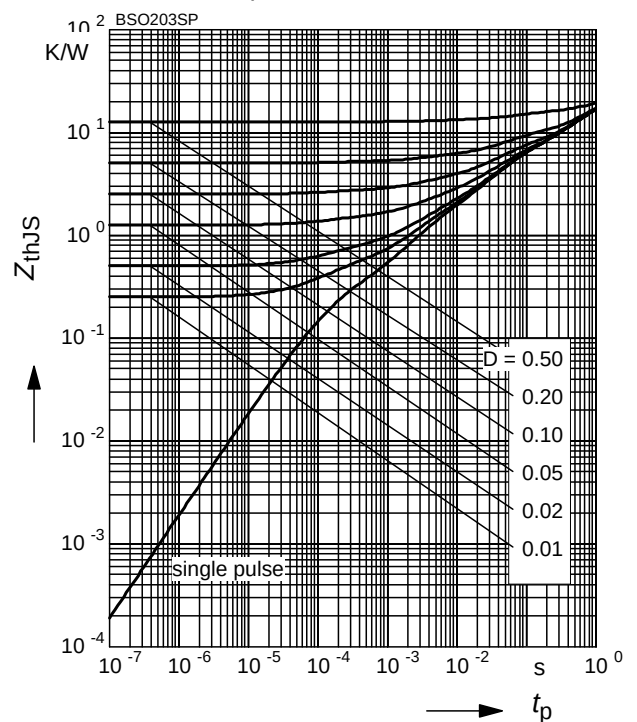
parameter:  $D = 0$ ,  $T_A = 25^\circ\text{C}$



### 4 Transient thermal impedance

$$Z_{\text{thJS}} = f(t_p)$$

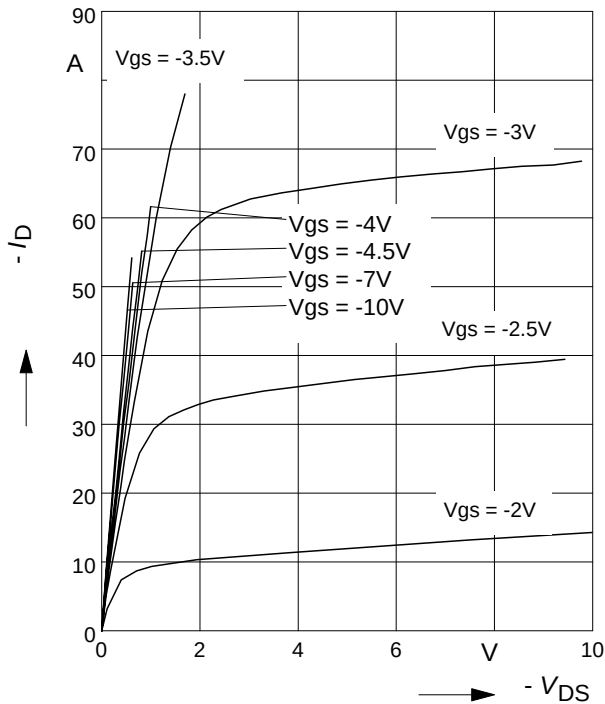
parameter:  $D = t_p / T$



### 5 Typ. output characteristic

$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$

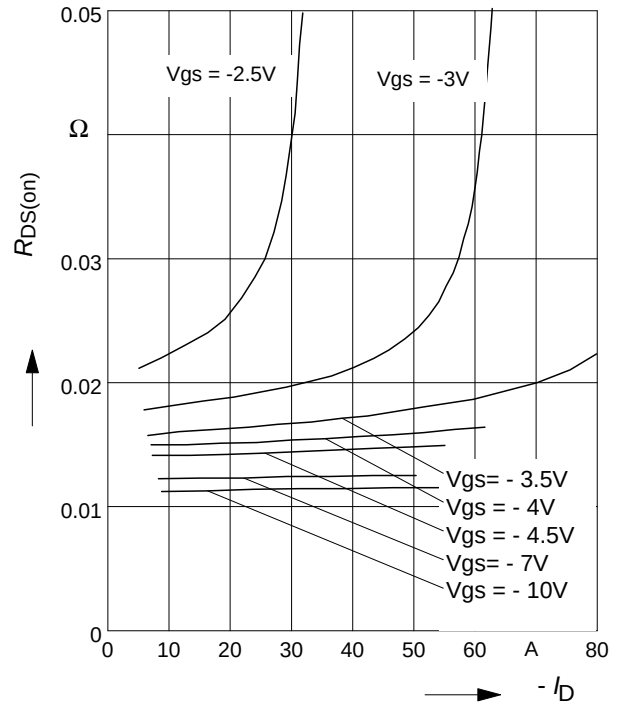
parameter:  $t_p = 80 \mu\text{s}$



### 6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$

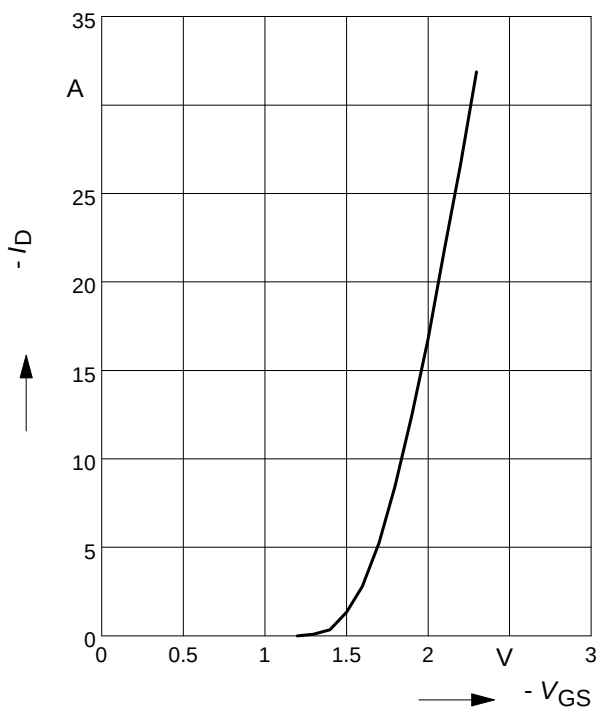
parameter:  $V_{GS}$



### 7 Typ. transfer characteristics

$I_D = f(V_{GS}); |V_{DS}| \geq 2 \times |I_D| \times R_{DS(on)max}$

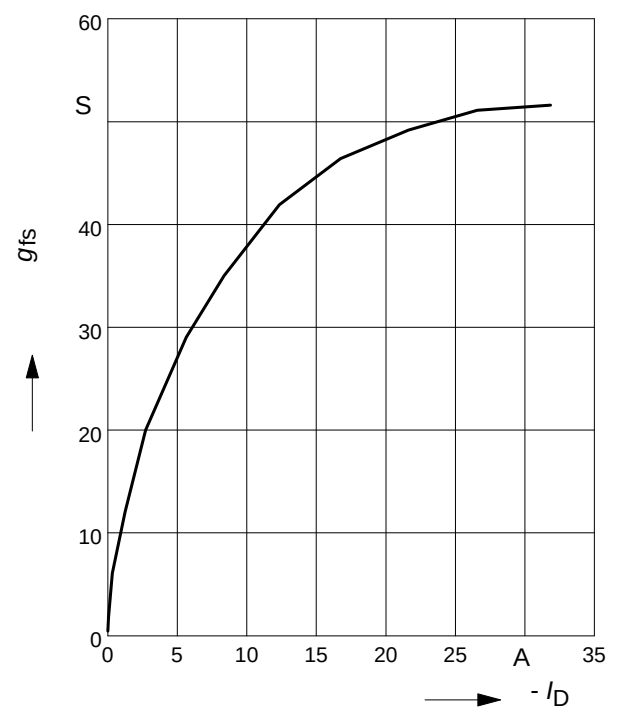
parameter:  $t_p = 80 \mu\text{s}$



### 8 Typ. forward transconductance

$g_{fs} = f(I_D); T_j = 25^\circ\text{C}$

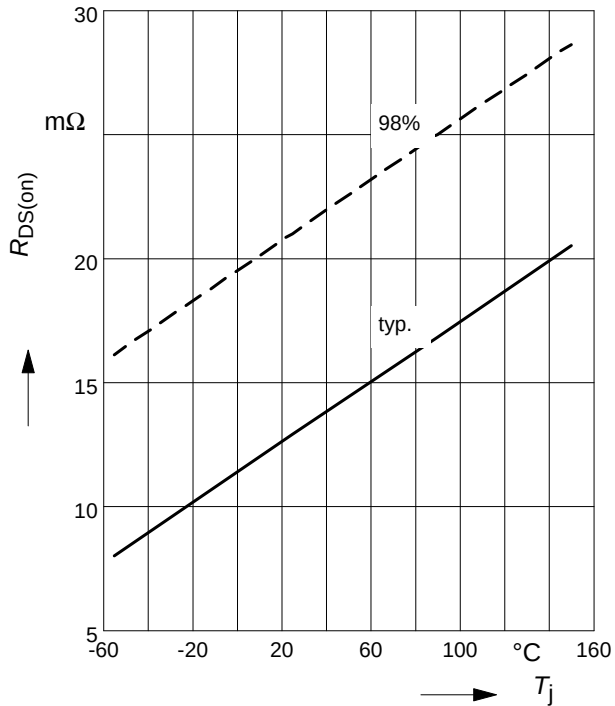
parameter:  $t_p = 80 \mu\text{s}$



## 9 Drain-source on-resistance

$$R_{DS(on)} = f(T_j)$$

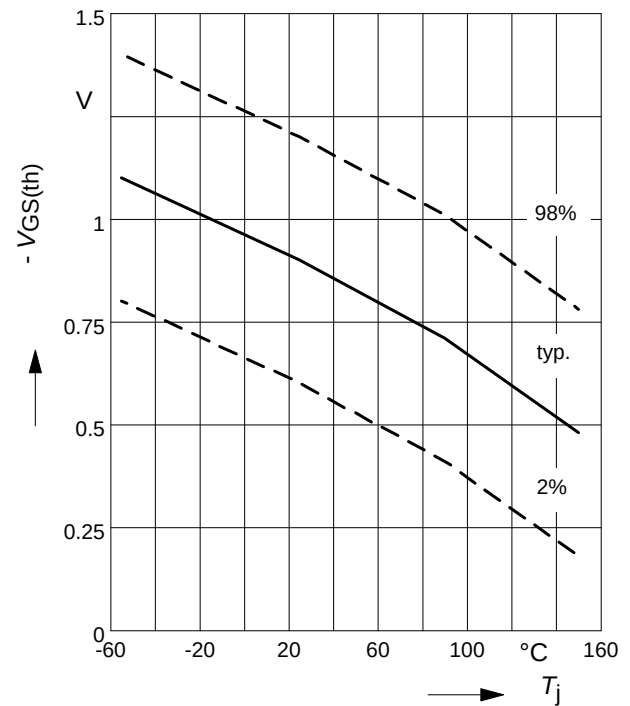
parameter:  $I_D = -9\text{ A}$ ,  $V_{GS} = -4.5\text{ V}$



## 10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

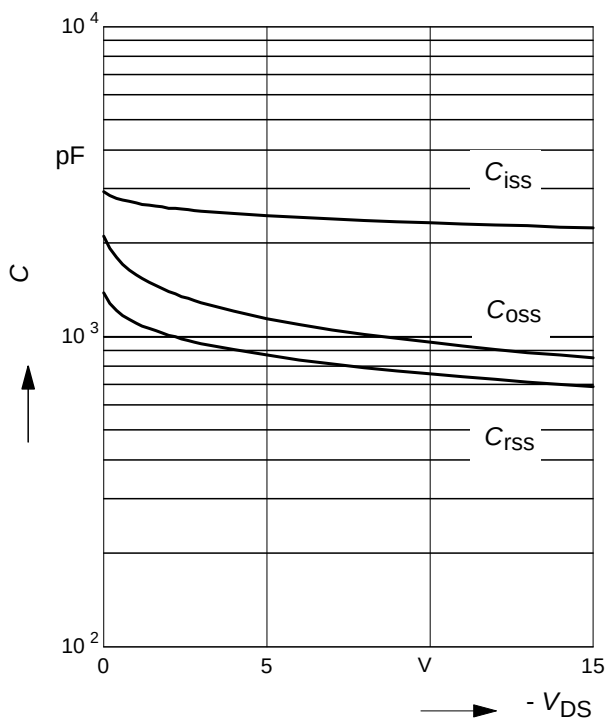
parameter:  $V_{GS} = V_{DS}$



## 11 Typ. capacitances

$$C = f(V_{DS})$$

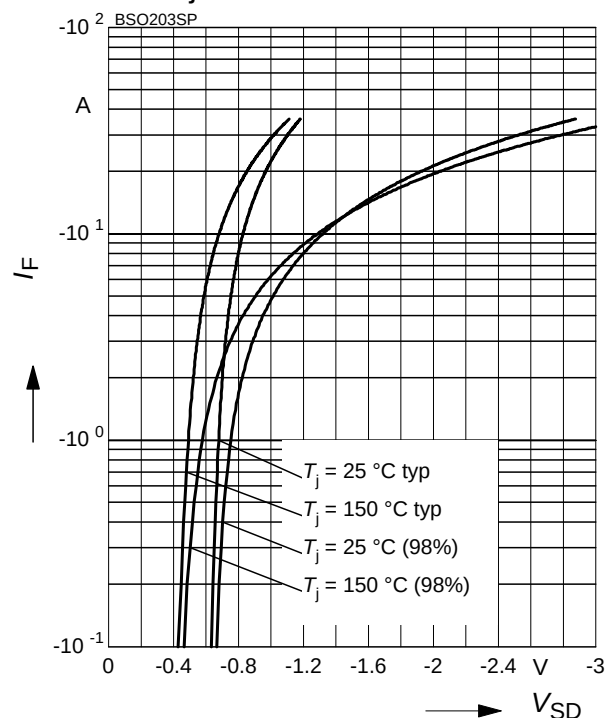
parameter:  $V_{GS}=0$ ,  $f=1\text{ MHz}$



## 12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

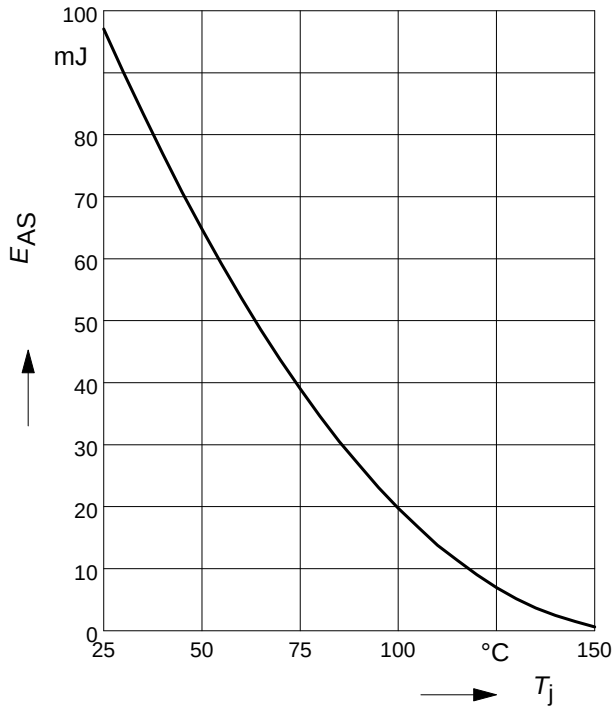
parameter:  $T_j$ ,  $t_p = 80\text{ }\mu\text{s}$



### 13 Typ. avalanche energy

$$E_{AS} = f(T_j), \text{ par.: } I_D = -9 \text{ A}$$

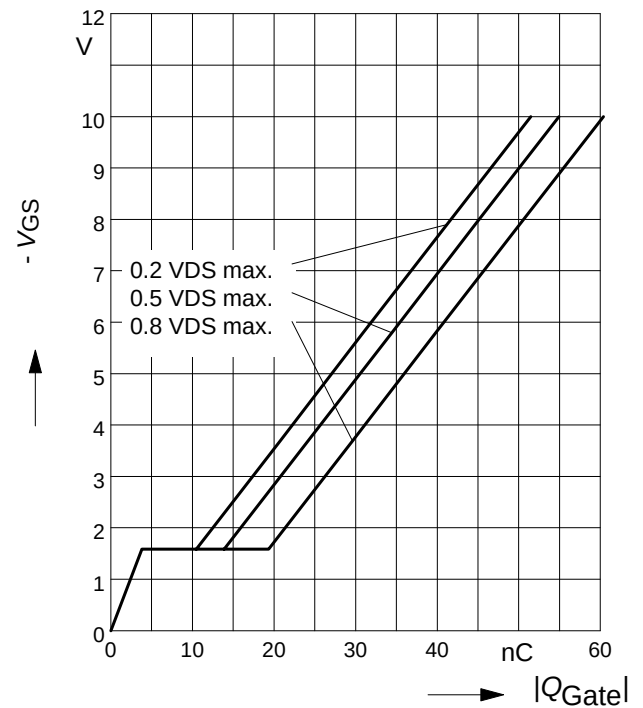
$$V_{DD} = -10 \text{ V}, R_{GS} = 25 \Omega$$



### 14 Typ. gate charge

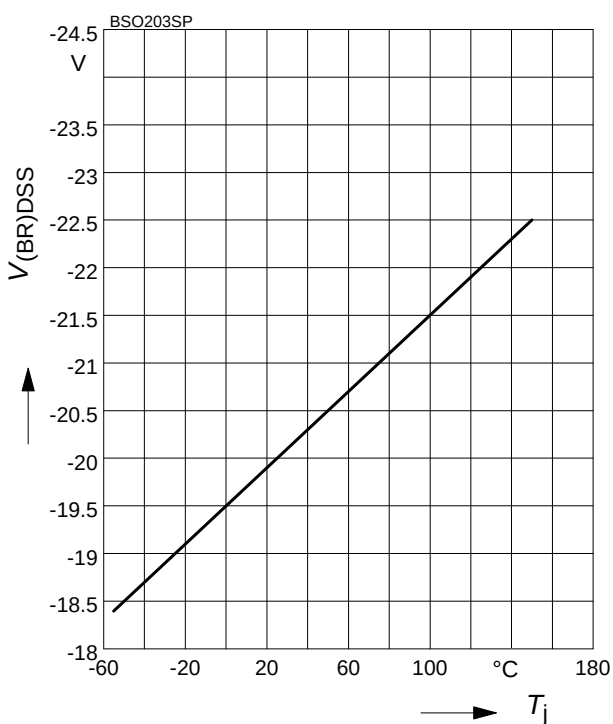
$$|V_{GS}| = f(Q_{Gate})$$

$$\text{parameter: } I_D = -9 \text{ A pulsed}$$



### 15 Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$



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